

MICROWAVE POWER GAAS FET

TIM4450-12UL

MICROWAVE SEMICONDUCTOR TECHNICAL DATA

FEATURES

- ·BROAD BAND INTERNALLY MATCHED FET
- ·HIGH POWER

P1dB= 41.5dBm at 4.4GHz to 5.0GHz

·HIGH GAIN

G1dB= 10.5dB at 4.4GHz to 5.0GHz

·LOW INTERMODULATION DISTORTION

IM3= -47dBc at Pout= 30.5dBm

Single Carrier Level

·HERMETICALLY SEALED PACKAGE



RF PERFORMANCE SPECIFICATIONS (Ta= 25°C)

| CHARACTERISTICS | SYMBOL | CONDITIONS | UNIT | MIN. | TYP. | MAX. |
|--|--------|---|------|------|------|------|
| Output Power at 1dB Gain Compression Point | P1dB | VDS= 10V IDSset= 2.6A f = 4.4 to 5.0GHz | dBm | 40.5 | 41.5 | |
| Power Gain at 1dB Gain Compression Point | G1dB | | dB | 9.5 | 10.5 | _ |
| Drain Current | IDS1 | | Α | _ | 3.2 | 3.8 |
| Gain Flatness | ΔG | | dB | | | ±0.6 |
| Power Added Efficiency | ηadd | | % | | 40 | _ |
| 3rd Order Intermodulation Distortion | IM3 | Two Tone Test Po= 30.5dBm, ∆f= 5MHz | dBc | -44 | -47 | |
| Drain Current | IDS2 | (Single Carrier Level) | Α | _ | 2.6 | 3.0 |
| Channel Temperature Rise | ΔTch | (VDS X IDS + Pin – P1dB) X Rth(c-c) | °C | | _ | 80 |

Recommended Gate Resistance(Rg): 68 Ω

ELECTRICAL CHARACTERISTICS (Ta= 25°C)

| CHARACTERISTICS | SYMBOL | CONDITIONS | UNIT | MIN. | TYP. | MAX. |
|-------------------------------|----------|----------------------|------|------|------|------|
| Transconductance | gm | VDS= 3V IDS= 4.0A | S | _ | 2.5 | _ |
| Pinch-off Voltage | VGSoff | VDS= 3V IDS= 40mA | V | -1.0 | -2.5 | -4.0 |
| Saturated Drain Current | IDSS | VDS= 3V VGS= 0V | Α | _ | 7.2 | _ |
| Gate-Source Breakdown Voltage | VGSO | IGS= -140μA | V | -5 | _ | _ |
| Thermal Resistance | Rth(c-c) | Channel to Case | °C/W | _ | 2.0 | 2.4 |

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- MICROWAVE SEMICONDUCTOR TECHNICAL DATA

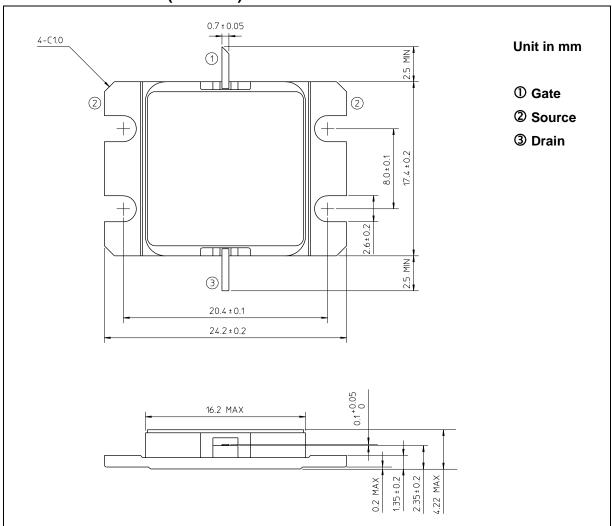


MICROWAVE SEMICONDUCTOR TECHNICAL DATA

ABSOLUTE MAXIMUM RATINGS (Ta= 25°C)

| CHARACTERISTICS | SYMBOL | UNIT | RATING |
|------------------------------------|--------|------|-------------|
| Drain-Source Voltage | VDS | V | 15 |
| Gate-Source Voltage | VGS | V | -5 |
| Drain Current | IDS | А | 10.0 |
| Total Power Dissipation (Tc= 25°C) | PT | W | 62.5 |
| Channel Temperature | Tch | °C | 175 |
| Storage Temperature | Tstg | °C | -65 to +175 |

PACKAGE OUTLINE (2-16G1B)

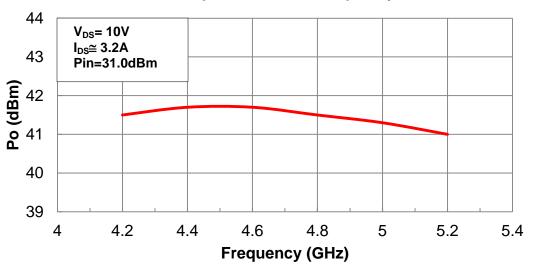


HANDLING PRECAUTIONS FOR PACKAGE MODEL

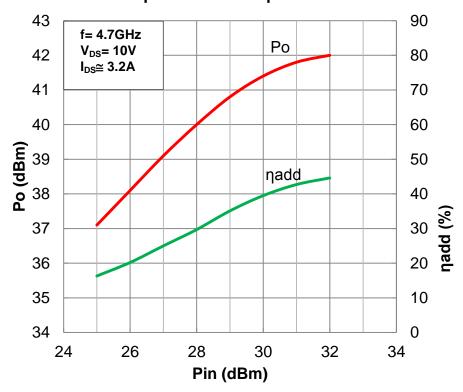
Soldering iron should be grounded and the operating time should not exceed 10 seconds at 260°C or 3 seconds at 350°C.

RF PERFORMANCE

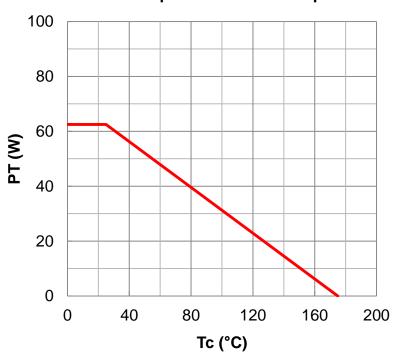
Output Power vs. Frequency



Output Power vs. Input Power



Power Dissipation vs. Case Temperature



IM3 vs. Output Power Characteristics

